

PACKAGE MATERIAL DECLARATION DATASHEET

Cypress Package Code	ZZ	Body Size (mil/mm)	4.4 mm
Package Weight – Site 1	B1: 49.6933 mg	Package Weight – Site 2	B1: 50.7016 mg
	B2: 59.9998 mg		B2: 55.3091 mg
	B3: 59.3970 mg		B3: 63.4832 mg
	B4: 56.3001 mg		
Package weight – Site 3	B1: 62.0000 mg		
_	B2: 61.5421 mg		

SUMMARY

The 16L-TSSOP package is qualified at three assembly sites. Packages from different assembly sites are likely to have different materials composition. However, Cypress guarantees that product ordered with a part number containing an "X" (e.g. CY7C1328G-133AXI, CY2308SXC-1HT) meets all requirement of the EU RoHS directive.

ASSEMBLY Site 1: Cypress Manufacturing Limited (CML)
Package Qualification Report # 060903, 115205, 124204 (Note 1)

I. DECLARATION OF PACKAGED UNITS

A. BANNED SUBSTANCES

Materials from Level A of the EIA/JIG/JGPSSI/EICTA Material Composition Declaration Guide and EU RoHS. Listed in the table below are materials that are neither contained nor intentionally added to this product.

Substances / Compounds	Weight by mg	PPM	Analysis Report (Note 2)
Cadmium and Cadmium Compounds	0	< 5.0	
Hexavalent Chromium and its Compounds	0	< 5.0	
Lead and Lead Compounds	0	< 5.0	CoA-ZZ16-
Mercury and Mercury Compounds	0	< 5.0	CML
Polybrominated Biphenyls (PBB)	0	< 5.0	
Polybrominated Diphenylethers (PBDE)	0	< 5.0	
Asbestos	0	0	As per MSDS
Azo colorants	0	0	As per MSDS
Ozone Depleting Substances	0	0	As per MSDS
Polychlorinated Biphenyls (PCBs)	0	0	As per MSDS
Polychlorinated Napthalenes	0	0	As per MSDS
Radioactive Substances	0	0	As per MSDS
Shortchain Chlorinated Paraffins	0	0	As per MSDS
Tributyl Tin (TBT) and Triphenyl Tin (TPT)	0	0	As per MSDS
Tributyl Tin Oxide (TBTO)	0	0	As per MSDS
Formaldehyde	0	0	As per MSDS

Note 1: Qualification reports are available at www.cypress.com. Access them by doing a Search on the Report #.

Note 2: Report available from Cypress Sales Offices or Distributors.

Note 3: Materials/substances not declared in Section I-A and I-B of this document are considered "non-existent in the product" or a natural impurity. In order to report exactly 100% material composition, some numbers were rounded to the nearest 0.01 percent. Cypress Semiconductor PMDD's are calculated using MSDS, Material Analysis Reports and Cypress Assembly site information.

Note 4: Actual testing performed on package family basis. Engineering calculations were applied to derive individual package data.



B1. MATERIAL COMPOSITION (Note 3)

NiPdAu using Standard Molding Compound

Material	Purpose of Use	Substance Composition	CAS Number	Weight by mg	% weight of substance per Homogeneous	PPM	%Weight of Substance per package
		Cu	7440-50-8	23.5978	94.4511%	474868	47.4868%
Leadframe	Base Material	Si	7440-21-3	0.2981	1.1933%	6000	0.6000%
Leauname	Dase Material	Mg	7439-95-4	0.0795	0.3182%	1600	0.1600%
		Ni	7440-02-0	1.0087	4.0374%	20299	2.0299%
	External	Ni	7440-02-0	0.1930	96.5200%	3885	0.3885%
Lead Finish	Plating	Pd	7440-05-3	0.0035	1.7400%	70	0.0070%
	Flatility	Au	7440-57-5	0.0035	1.7400%	70	0.0070%
	Adhesive	Ag	7440-22-4	0.1687	79.9953%	3395	0.3395%
		Proprietary bismaleimide	Trade Secret	0.0211	9.9906%	424	0.0424%
Die Attach		Proprietary polymer	Trade Secret	0.0084	4.0057%	170	0.0170%
		Methacrylate	Trade Secret	0.0042	2.0028%	85	0.0085%
		Acrylate ester	Trade Secret	0.0042	2.0028%	85	0.0085%
		Organic peroxide	Trade Secret	0.0042	2.0028%	85	0.0085%
Die	Circuit	Si	7440-21-3	2.9715	100.0000%	59796	5.9796%
Wire	Interconnect	Au	7440-57-5	0.6112	100.0000%	12299	1.2299%
		Epoxy resin	85954-11-6	1.0385	5.0132%	20899	2.0899%
		Phenol resin	26834-02-6	1.0385	5.0132%	20899	2.0899%
Mold	Enconculation	Brominated epoxy resin	68541-56-0	0.2087	1.0074%	4200	0.4200%
Compound	Encapsulation	Antimony trioxide	1309-64-4	0.0994	0.4797%	2000	0.2000%
		Silica	60676-86-0	18.1219	87.4790%	364675	36.4675%
		Others	Trade Secret	0.2087	1.0074%	4200	0.4200%

Package Weight (mg):

49.6933

% Total: 100.0000

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Note 4: Actual testing performed on package family basis. Engineering calculations were applied to derive individual package data.



B2. MATERIAL COMPOSITION (Note 3) NiPdAu using Green Molding Compound

Material	Purpose of Use	Substance Composition	CAS Number	Weight by mg	% Weight of Substance per Homogeneous Material	PPM	% Weight of Substance per package
		Cu	7440-50-8	26.3370	97.4100	438,950	43.8950
Lead frame	Base Material	Fe	7439-89-6	0.6489	2.4000	10,815	1.0815
Lead IIaille	Dase Material	Р	7723-14-0	0.0189	0.0700	315	0.0315
		Zn	7440-66-6	0.0324	0.1200	541	0.0541
	External	Ni	7440-02-0	0.5432	96.5203	9,054	0.9054
Lead Finish	Plating	Pd	7440-05-3	0.0098	1.7370	163	0.0163
		Au	7440-57-5	0.0098	1.7427	163	0.0163
	Adhesive	Ag	7440-22-4	0.0597	80.0000	996	0.0996
		Proprietary bismaleimide	Trade Secret	0.0067	9.0000	112	0.0112
Die Attach		Proprietary polymer	Trade Secret	0.0037	5.0000	62	0.0062
		Methacrylate	Trade Secret	0.0015	2.0000	25	0.0025
		Acrylate ester	Trade Secret	0.0015	2.0000	25	0.0025
		Organic peroxide	Trade Secret	0.0015	2.0000	25	0.0025
Die	Circuit	Si	7440-21-3	1.0453	100.0000	17,422	1.7422
Wire	Interconnect	Au	7440-57-5	1.1295	100.0000	18,825	1.8825
Mala		SiO2	60676-86-0	26.8339	89.0000	447,232	44.7232
Mold	Encapsulation	Phenol Resin	Trade Secret	1.5075	5.0000	25,125	2.5125
Compound		Epoxy Resin	Trade Secret	1.8090	6.0000	30,150	3.0150

Package Weight (mg): 59.9998 %Total: 100.0000

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Note 4: Actual testing performed on package family basis. Engineering calculations were applied to derive individual package data.



B3. MATERIAL COMPOSITION (Note 3) Copper Wire using NiPdAu and Kyocera Molding Compound

Material	Purpose of Use	Substance Composition	CAS Number	Weight by mg	% Weight of Substance per Homogeneous Material	PPM	% Weight of Substance per package
		Cu	7440-50-8	26.3370	97.4100	443,406	44.3406
Lead frame	Base Material	Fe	7439-89-6	0.6489	2.4000	10,925	1.0925
Lead Hairie	Dase Material	Р	7723-14-0	0.0189	0.0700	319	0.0319
		Zn	7440-66-6	0.0324	0.1200	546	0.0546
	External	Ni	7440-02-0	0.5432	96.5200	9,145	0.9145
Lead Finish	Plating	Pd	7440-05-3	0.0098	1.7400	165	0.0165
		Au	7440-57-5	0.0098	1.7400	165	0.0165
		Ag	7440-22-4	0.0597	80.0000	1,005	0.1005
		Proprietary bismaleimide	Trade Secret	0.0067	9.0000	113	0.0113
Die Attach	Adhesive	Proprietary polymer	Trade Secret	0.0037	5.0000	63	0.0063
		Methacrylate	Trade Secret	0.0015	2.0000	25	0.0025
		Acrylate ester	Trade Secret	0.0015	2.0000	25	0.0025
		Organic peroxide	Trade Secret	0.0015	2.0000	25	0.0025
Die	Circuit	Si	7440-21-3	1.0453	100.0000	17,599	1.7599
Wire	Interconnect	Cu	7440-50-8	0.5267	100.0000	8,867	0.8867
		SiO2	60676-86-0	26.8339	89.0000	451,771	45.1771
Mold	Encapsulation	Phenol Resin	Trade Secret	1.5075	5.0000	25,380	2.5380
Compound	Encapsulation	Epoxy Resin	Trade Secret	1.7336	5.7500	29,187	2.9187
		Carbon Black	1333-86-4	0.0754	0.2500	1,269	0.1269

Package Weight (mg):	59.3970	%Total:	100.0000

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Note 4: Actual testing performed on package family basis. Engineering calculations were applied to derive individual package data.



II. DECLARATION OF PACKAGING INDIRECT MATERIALS

Туре	Material	Lead PPM	Cadmium PPM	Cr VI PPM	Mercury PPM	PBB PPM	PBDE PPM	Analysis Report (Note2)
Tube	Plastic Tube	<5.0	<5.0	<5.0	<5.0	<5.0	<5.0	CoA-PLTB-R
Tube	End Plug	< 5.0	<5.0	<5.0	<5.0	<5.0	<5.0	CoA-EPLG-R
Tape and Reel	Carrier Tape	<5.0	<5.0	<5.0	<5.0	<5.0	<5.0	CoA-CART-R
	Moisture Barrier Bag	<5.0	<5.0	<5.0	<5.0	<5.0	<5.0	CoA-MBBG-R
	Dessicant	< 5.0	<5.0	<5.0	<5.0	<5.0	<5.0	CoA-DESS-R
	HIC	<5.0	<5.0	<5.0	<5.0	<5.0	<5.0	CoA-HIC-R
Others	Bubble Pack	<5.0	<5.0	<5.0	<5.0	<10.0	<10.0	CoA-BUBB-R
	Carton Label	<10.0	<5.0	<5.0	<5.0	<5.0	<5.0	CoA-CRTN-R
	Inner Label	<10.0	<5.0	<5.0	<5.0	<5.0	<5.0	CoA-LBL-R
	Shielding Bag	<5.0	< 5.0	< 5.0	< 5.0	< 5.0	< 5.0	CoA-SBAG-R

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Note 4: Actual testing performed on package family basis. Engineering calculations were applied to derive individual package data.



ASSEMBLY Site 2: Orient Semiconductor Electronics Taiwan (OSET)
Package Qualification Report # 043102, # 111405, # 120605, #131404 (Note 1)

I. DECLARATION OF PACKAGED UNITS

A. BANNED SUBSTANCES

Materials from Level A of the EIA/JIG/JGPSSI/EICTA Material Composition Declaration Guide and EU RoHS. Listed in the table below are materials that are neither contained nor intentionally added to this product.

Substances / Compounds	Weight by mg	PPM	Analysis Report (Note 2)
Cadmium and Cadmium Compounds	0	< 5.0	
Hexavalent Chromium and its Compounds	0	< 5.0	
Lead and Lead Compounds	0	< 5.0	CoA-ZZ16-
Mercury and Mercury Compounds	0	< 5.0	OSET
Polybrominated Biphenyls (PBB)	0	< 5.0	
Polybrominated Diphenylethers (PBDE)	0	< 5.0	
Asbestos	0	0	As per MSDS
Azo colorants	0	0	As per MSDS
Ozone Depleting Substances	0	0	As per MSDS
Polychlorinated Biphenyls (PCBs)	0	0	As per MSDS
Polychlorinated Napthalenes	0	0	As per MSDS
Radioactive Substances	0	0	As per MSDS
Shortchain Chlorinated Paraffins	0	0	As per MSDS
Tributyl Tin (TBT) and Triphenyl Tin (TPT)	0	0	As per MSDS
Tributyl Tin Oxide (TBTO)	0	0	As per MSDS
Formaldehyde	0	0	As per MSDS

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Note 2: Report available from Cypress Sales Offices or Distributors.

Note 3: Materials/substances not declared in Section I-A and I-B of this document are considered "non-existent in the product" or a natural impurity. In order to report exactly 100% material composition, some numbers were rounded to the nearest 0.01 percent. Cypress Semiconductor PMDD's are calculated using MSDS, Material Analysis Reports and Cypress Assembly site information.

Note 4: Actual testing performed on package family basis. Engineering calculations were applied to derive individual package data.



B1. MATERIAL COMPOSITION (Note 3) Pure Sn using Hitachi Mold Compound

Material	Purpose of Use	Substance Composition	CAS Number	Weight by mg	% weight of substance per Homogeneous	РРМ	% Weight of Substance per package
		Cu	7440-50-8	14.8706	93.8800%	294,063	29.4063%
		Si	7440-21-3	0.1901	1.2000%	3,759	0.3759%
Leadframe	Base Material	Mg	7439-95-4	0.0507	0.3200%	1,002	0.1002%
		Ag	7440-22-4	0.0602	0.3800%	1,190	0.1190%
		Ni	7440-02-0	0.6700	4.2300%	13,250	1.3250%
Lead Finish	External Plating	Sn	7440-31-5	1.3000	100.0000%	25,707	2.5707%
		Epoxy resin	Trade Secret	0.1600	20.2500%	3,163	0.3163%
Die Attach	Adhesive	Ag	7440-22-4	0.5900	74.6800%	11,667	1.1667%
		Metal	Trade Secret	0.0400	5.0600%	790	0.0790%
Die	Circuit	Si	7440-21-3	1.8700	100.0000%	36,979	3.6979%
Wire	Interconnect	Au	7440-57-5	0.1700	100.0000%	3,362	0.3362%
		Epoxy resin	85954-11-6	1.5365	5.0000%	30,323	3.0323%
		Phenol resin	26834-02-6	1.2292	4.0000%	24,246	2.4246%
Mold Compound	Encapsulation	Aromatic Phosphate	Trade Secret	0.3073	1.0000%	6,077	0.6077%
		Carbon black	1333-86-4	0.0615	0.2000%	1,155	0.1155%
		Silica	60676-86-0	27.5955	89.8000%	543,266	54.3266%

Package Weight (mg): 50.7016 % Total: 100.0000

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Note 4: Actual testing performed on package family basis. Engineering calculations were applied to derive individual package data.





B2. MATERIAL COMPOSITION (Note 3) Pure Sn using Sumitomo Mold Compound

Material	Purpose of Use	Substance Composition	CAS Number	Weight by mg	% weight of substance per Homogeneous	PPM	% Weight of Substance per package
		Copper	7440-50-8	18.6173	95.5000%	336605	33.6605%
		Silicon	7440-21-3	0.1413	0.7250%	2555	0.2555%
Leadframe	Base Material	Nickel	7440-02-0	0.6238	3.2000%	11279	1.1279%
		Magnesium	7439-95-4	0.0341	0.1750%	617	0.0617%
		Silver	7440-22-4	0.0780	0.4000%	1410	0.1410%
Lead Finish	External Plating	Sn	7440-31-5	1.5280	100.0000%	27627	2.7627%
		Silver Flake	7440-22-4	0.2175	79.0000%	3932	0.3932%
		Epoxy Acrylate	15625-89-5	0.0206	7.5000%	373	0.0373%
	Adhesive	Substituted	68490-66-4	0.0028	1.0000%	50	0.0050%
Die Attach		Polyamine					
		Bisphenol F	28064-14-4	0.0206	7.5000%	373	0.0373%
		2-Ethylhexyl	2461-15-6	0.0138	5.0000%	249	0.0249%
		Glycidyl Ether					
Die	Circuit	Si	7440-21-3	3.2073	100.0000%	57989	5.7989%
Wire	Interconnect	Au	7440-57-5	0.3322	100.0000%	6006	0.6006%
		Epoxy resin A	Trade Secret	1.5236	5.0000%	27547	2.7547%
		Epoxy,Cresol Novolac	29690-82-2	1.5236	5.0000%	27547	2.7547%
		Phenol resin	Trade Secret	1.5236	5.0000%	27547	2.7547%
Mold Compound	Encapsulation	Metal Hydroxide	Trade Secret	1.5236	5.0000%	27547	2.7547%
,	'	Carbon Black	1333-86-4	0.0914	0.3000%	1653	0.1653%
		Silica Fused	60676-86-0	21.1474	69.4000%	382349	38.2349%
		Silica Fused	76361-86-9	3.0472	10.0000%	55094	5.5094%
		Silica, crystalline	14808-60-7	0.0914	0.3000%	1653	0.1653%

Package Weight (mg): 55.3091 % Total: 100.0000

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Note 4: Actual testing performed on package family basis. Engineering calculations were applied to derive individual package data.





B3: MATERIAL COMPOSITION (Note 3) Using Copper Wire

Material	Purpose of Use	Substance Composition	CAS Number	Weight by mg	% weight of substance per Homogeneous	PPM	% Weight of Substance per package
		Copper	7440-50-8	18.7419	95.5000%	295,226	29.5226%
		Silicon	7440-21-3	0.1423	0.7250%	2,242	0.2242%
Leadframe	Base Material	Nickel	7440-02-0	0.6280	3.2000%	9,892	0.9892%
		Magnesium	7439-95-4	0.0343	0.1750%	540	0.0540%
		Silver	7440-22-4	0.0785	0.4000%	1,237	0.1237%
Lead Finish	External Plating	Sn	7440-31-5	1.4821	100.0000%	23,346	2.3346%
		Silver	7440-22-4	0.1253	74.0000%	1,974	0.1974%
		Epoxy resin A	9003-36-5	0.0068	4.0000%	107	0.0107%
		Epoxy resin B	Trade Secret	0.0102	6.0000%	161	0.0161%
		Diluent A	Trade Secret	0.0068	4.0000%	107	0.0107%
Die Attach	Adhesive	Diluent B	Trade Secret	0.0102	6.0000%	161	0.0161%
Die Attach	Adilesive	Phenolic Hardener	Trade Secret	0.0085	5.0000%	134	0.0134%
		Dicyandiamide	461-58-5	0.0008	0.5000%	13	0.0013%
		Organic peroxide	Trade Secret	0.0008	0.5000%	13	0.0013%
Die	Circuit	Si	7440-21-3	2.8922	100.0000%	45,559	4.5559%
Wire	Interconnect	Copper	7440-50-8	0.1106	100.0000%	1,742	0.1742%
		Epoxy resin A	Trade Secret	1.9602	5.0000%	30,877	3.0877%
		Epoxy,Cresol Novolac	29690-82-2	1.9602	5.0000%	30,877	3.0877%
Male		Phenol resin	Trade Secret	1.9602	5.0000%	30,877	3.0877%
Mold	Encapsulation	Metal Hydroxide	Trade Secret	1.9602	5.0000%	30,877	3.0877%
Compound		Carbon Black	1333-86-4	0.1176	0.3000%	1,852	0.1852%
		Silica Fused A	60676-86-0	27.2075	69.4000%	428,579	42.8579%
		Silica Fused B	76361-86-9	3.9204	10.0000%	61,755	6.1755%
		Silica, crystalline	14808-60-7	0.1176	0.3000%	1,852	0.1852%

Package Weight (mg): 63.4832 % Total: 100.0000

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Note 4: Actual testing performed on package family basis. Engineering calculations were applied to derive individual package data.



B4: MATERIAL COMPOSITION (Note 3) Using NiPdAu

Material	Purpose of Use	Substance Composition	CAS Number	Weight by mg	% weight of substance per Homogeneous	PPM	% Weight of Substance per package
		Copper	7440-50-8	14.0777	96.2000%	250,047	25.0047%
Leadframe	Base Material	Silicon	7440-21-3	0.0951	0.6500%	1,690	0.1690%
Leadifairie	Dase Material	Nickel	7440-02-0	0.4390	3.0000%	7,798	0.7798%
		Magnesium	7439-95-4	0.0220	0.1500%	390	0.0390%
	External	Nickel	7440-02-0	0.3535	96.5204%	6,279	0.6279%
Lead Finish	Plating	Palladium	7440-05-3	0.0064	1.7370%	113	0.0113%
	riating	Gold	7440-57-5	0.0064	1.7427%	113	0.0113%
		Ag	7440-22-4	0.1707	84.0000%	3,032	0.3032%
	Adhesive	Allyl Compound	Trade Secret	0.0138	6.8000%	245	0.0245%
		Epoxy Resin A	9003-36-5	0.0030	1.5000%	54	0.0054%
		Epoxy Resin B	Trade Secret	0.0041	2.0000%	72	0.0072%
Die Attach		Diluent A	Trade Secret	0.0030	1.5000%	54	0.0054%
Die Attach		Diluent B	Trade Secret	0.0041	2.0000%	72	0.0072%
		Hardener	461-58-5	0.0041	2.0000%	72	0.0072%
		Dicyandiamide	461-58-5	0.0002	0.1000%	4	0.0004%
		Organic	Trade Secret				
		Peroxide		0.0002	0.1000%	4	0.0004%
Die	Circuit	Si	7440-21-3	2.8447	100.0000%	50,528	5.0528%
Wire	Interconnect	Gold	7440-57-5	0.5130	100.0000%	9,112	0.9112%
		SiO2	14808-60-7	33.8708	89.7500%	601,612	60.1612%
Mold		Epoxy Resin A	Trade Secret	0.9435	2.5000%	16,758	1.6758%
Compound	Encapsulation	Epoxy Resin B	Trade Secret	0.9435	2.5000%	16,758	1.6758%
Compound		Phenol Resin	Trade Secret	1.8870	5.0000%	33,516	3.3516%
		Carbon Black	1333-86-4	0.0943	0.2500%	1,676	0.1676%

Package Weight (mg): 56.3001 % Total: 100.0000

II. DECLARATION OF PACKAGING INDIRECT MATERIALS

Туре	Material	Lead PPM	Cadmium PPM	Cr VI PPM	Mercury PPM	PBB PPM	PBDE PPM	Analysis Report (Note2)
Tube	Plastic Tube	<5.0	<5.0	<5.0	<5.0	<5.0	<5.0	CoA-PLTB-R
Tube	End Plug	<5.0	<5.0	<5.0	<5.0	<5.0	<5.0	CoA-EPLG-R
Tape and Reel	Carrier Tape	<5.0	<5.0	<5.0	<5.0	<5.0	<5.0	CoA-CART-R
	Moisture Barrier Bag	<5.0	<5.0	<5.0	<5.0	<5.0	<5.0	CoA-MBBG-R
	Dessicant	<5.0	<5.0	<5.0	<5.0	<5.0	<5.0	CoA-DESS-R
	HIC	<5.0	<5.0	<5.0	<5.0	<5.0	<5.0	CoA-HIC-R
Others	Bubble Pack	<5.0	<5.0	<5.0	<5.0	<10.0	<10.0	CoA-BUBB-R
	Carton Label	<10.0	<5.0	<5.0	<5.0	<5.0	<5.0	CoA-CRTN-R
	Inner Label	<10.0	<5.0	<5.0	<5.0	<5.0	<5.0	CoA-LBL-R
	Shielding Bag	<5.0	< 5.0	< 5.0	< 5.0	< 5.0	< 5.0	CoA-SBAG-R

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Note 4: Actual testing performed on package family basis. Engineering calculations were applied to derive individual package data.



ASSEMBLY Site 3: Amkor Technology Philippines (P1/P2) Package Qualification Report # 032101, 122204 (Note 1)

I. DECLARATION OF PACKAGED UNITS

A. BANNED SUBSTANCES

Materials from Level A of the EIA/JIG/JGPSSI/EICTA Material Composition Declaration Guide and EU RoHS. Listed in the table below are materials that are neither contained nor intentionally added to this product.

Substances / Compounds	Weight by mg	PPM	Analysis Report (Note 2)
Cadmium and Cadmium Compounds	0	< 5.0	
Hexavalent Chromium and its Compounds	0	< 5.0	CoA-ZZ16-
Lead and Lead Compounds	0	< 5.0	Amkor
Mercury and Mercury Compounds	0	< 5.0	Philippines
Polybrominated Biphenyls (PBB)	0	< 5.0	(P1/P2)
Polybrominated Diphenylethers (PBDE)	0	< 5.0	
Asbestos	0	0	As per MSDS
Azo colorants	0	0	As per MSDS
Ozone Depleting Substances	0	0	As per MSDS
Polychlorinated Biphenyls (PCBs)	0	0	As per MSDS
Polychlorinated Napthalenes	0	0	As per MSDS
Radioactive Substances	0	0	As per MSDS
Shortchain Chlorinated Paraffins	0	0	As per MSDS
Tributyl Tin (TBT) and Triphenyl Tin (TPT)	0	0	As per MSDS
Tributyl Tin Oxide (TBTO)	0	0	As per MSDS
Formaldehyde	0	0	As per MSDS

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Note 4: Actual testing performed on package family basis. Engineering calculations were applied to derive individual package data.





B1. MATERIAL COMPOSITION (Note 3)

Using Au Wire

Material	Purpose of Use	Substance Composition	CAS Number	Weight by mg	% weight of substance per Homogene ous	PPM	%% Weight of Substance per package
		Cu	7440-50-8	26.4196	94.0200%	426,123	42.6123%
		Ni	7440-02-0	0.8205	2.9200%	13,234	1.3234%
Leadframe	Base Material	Si	7440-21-3	0.1798	0.6400%	2,901	0.2901%
		Mg	7439-95-4	0.0393	0.1400%	635	0.0635%
		Ag	7440-22-4	0.6407	2.2800%	10,334	1.0334%
Lead Finish	External Plating Sn		7440-31-5	1.5700	100.0000%	25,323	2.5323%
	Adhesive	Resin	Trade Secret	0.2700	20.6100%	4,355	0.4355%
		Ag	7440-22-4	0.9201	70.2400%	14,841	1.4841%
Die Attach		Metal Oxide	Trade Secret	0.0400	3.0500%	644	0.0644%
Die Attach		Amine	Trade Secret	0.0400	3.0500%	644	0.0644%
		Gamma	Trade Secret	0.0400	3.0500%	644	0.0644%
		Butyrolactone					
Die	Circuit	Si	7440-21-3	3.8700	100.0000%	62,419	6.2419%
Wire	Interconnect	Au	7440-57-5	0.4000	100.0000%	6,452	0.6452%
Mold	Encapsulation	Filler	Trade Secret	22.4700	84.0000%	362,419	36.2419%
Compound		Phenol Resin	Trade Secret	1.8591	6.9500%	29,986	2.9986%
Compound		Epoxy Resin	Trade Secret	2.4209	9.0500%	39,046	3.9046%

Package Weight (mg): 62.0000 % Total: 100.0000

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B2. MATERIAL COMPOSITION (Note 3)

Using Cu Wire

Material	Purpose of Use	Substance Composition	CAS Number	Weight by mg	% weight of substance per Homogeneous	PPM	%% Weight of Substance per package
		Cu	7440-50-8	26.9433	95.2450	437,803	43.7803%
		Fe	7439-89-6	0.6636	2.3457	10,782	1.0782%
Leadframe	Base Material	Zn	7440-66-6	0.0332	0.1173	539	0.0539%
		Р	7723-14-0	0.0083	0.0293	135	0.0135%
		Ag	7440-22-4	0.6401	2.2627	10,401	1.0401%
Lead Finish	External Plating	External Sn		1.5569	100.0000	25,297	2.5297%
	Adhesive	Epoxy resin A	Trade Secret	0.0769	7.0000	1,249	0.1249%
		Epoxy Resin B	Trade Secret	0.0439	4.0000	714	0.0714%
		Ag	7440-22-4	0.8457	77.0000	13,742	1.3742%
		Lactone	Trade Secret	0.0439	4.0000	714	0.0714%
Die Attach		Polyoxypropyle nediamine	Trade Secret	0.0439	4.0000	714	0.0714%
		2,6-Diglycidyl phenyl allyl ether oligomer	Trade Secret	0.0439	4.0000	714	0.0714%
Die	Circuit	Silicon	7440-21-3	4.1400	100.0000	67,271	6.7271%
Wire	Interconnect	Cu	7440-50-8	0.1166	100.0000	1,894	0.1894%
	Encapsulation	Epoxy resin	Trade Secret	2.3708	9.0000	38,523	3.8523%
Mold		SiO2 Filler	60676-86-0	22.1272	84.0000	359,546	35.9546%
Compound		Phenol Resin	Trade Secret	1.7122	6.5000	27,822	2.7822%
		Carbon Black	1333-86-4	0.1317	0.5000	2,140	0.2140%

Package Weight (mg): 61.5421 % Total: 100.0000

II. DECLARATION OF PACKAGING INDIRECT MATERIALS

Туре	Material	Lead PPM	Cadmium PPM	Cr VI PPM	Mercury PPM	PBB PPM	PBDE PPM	Analysis Report (Note2)
Tube	Plastic Tube	<5.0	<5.0	<5.0	<5.0	<5.0	<5.0	CoA-PLTB-R
Tube	End Plug	<5.0	<5.0	<5.0	<5.0	<5.0	<5.0	CoA-EPLG-R
Tape and Carrier Tape		<5.0	<5.0	<5.0	<5.0	<5.0	<5.0	CoA-CART-R
	Moisture Barrier Bag	<5.0	<5.0	<5.0	<5.0	<5.0	<5.0	CoA-MBBG-R
	Dessicant	<5.0	<5.0	< 5.0	<5.0	<5.0	<5.0	CoA-DESS-R
	HIC	<5.0	<5.0	<5.0	<5.0	<5.0	<5.0	CoA-HIC-R
Others	Bubble Pack	<5.0	<5.0	< 5.0	<5.0	<10.0	<10.0	CoA-BUBB-R
	Carton Label	<10.0	<5.0	<5.0	<5.0	<5.0	<5.0	CoA-CRTN-R
	Inner Label	<10.0	<5.0	<5.0	<5.0	<5.0	<5.0	CoA-LBL-R
	Shielding Bag	<5.0	< 5.0	< 5.0	< 5.0	< 5.0	< 5.0	CoA-SBAG-R

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16L-TSSOP Pb-Free Package

Document History Page

Document Title: 16L TSSOP PB-FREE PACKAGE MATERIAL DECLARATION DATASHEET

Document Number: 001-04165

Rev.	ECN No.	Orig. of Change	Description of Change
**	390637	YXP	New document.
*A	401531	GFJ	Added assembly site 3. Added Package weight and word "PMDD". Change the word from two to three in summary of qualified assembly sites. Added natural impurity in note 3 and added note 4.
*B	1350126	MRB	 Updated Cypress Logo Deleted reference QTP # 015107 and change to QTP # 060903 on Assembly site 1. Deleted CoA-SP28-T and change to CoA-ZZ16-T on Assembly site 2. Added the percent weight per homogeneous material and weight of substance on the material composition Deleted Declaration of Packaging/Indirect Materials on Assembly site 1 and 2. Updated and added Lead, Cr+VI, PBB and PBDE on the Declaration of Packaging/Indirect Materials.
*C	2616718	МАНА	Deleted the following items from Table B. Material Composition of Assembly Site 2: 1. Antimony and its compounds 2. Bromine organic compound 3. Organic phosphorous compound (Catalyst) Revised the following items from Table B. Material Composition of Assembly Site 2: 1. PPM 2. % Weight of Substance per Package
*D	2732541	HLR	Changed the reference QTP No. 024701 to 043102 for Assembly Site 2.
*E	3044455	МАНА	Deleted Fe and Zn from the material composition of assembly site 1. Revised the % weight of substance per Homogeneous values of the lead frame of assembly site 1. Revised the PPM and %Weight of Substance per package values of assembly site 1.
*F	3331862	HLR	Recomputed material composition table of assembly site 1.
*G	3377033	EBZ	Added package weight B2 for Site 2. Added QTP#111405 for Assembly Site- 2. Added B2: Material Composition table for Site-2.
*H	3615449	HLR	Added material composition using Green Mold Compound on Assembly Site 1. Reference QTP No. 115205. Added Table 2 for Assembly Sites 1 and 2. Updated the material composition of Assembly Site 2 – B1 and Assembly Site 3 to reflect 4 decimal places on values.
*	3607050	COPI	Added PMDD for Assembly Site 2-B3 – OSE Taiwan Copper Qualification under QTP # 120605.

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Document Number: 001-04165

Rev.	ECN No.	Orig. of Change	Description of Change
*J	3931592	UDR	Added B3 for Assembly Site 1 – CML-Autoline Copper Qualification under QTP # 124204. Added QTP # 124204 at Assembly Site 1 Package Qualification Reports Added B3. Material Composition – Using Copper Wire with NiPdAu and Kyocera mold Compound.
*K	4066912	YUM	Added assembly site name in the Assembly heading in site 1, 2 and 3. Changed assembly code to assembly site name in site 1, 2 and 3.
*L	4111187	JARG	Added Material Composition for Assembly Site 3 B2 Using Cu Wire Assembled at Amkor Philippines.
*M	4290995	HLR	Added Material Composition for Assembly Site 2 – B4 using NiPdAu. Reference to QTP No. 131404. Corrected the total package weight of B2 Material Composition for Assembly Site 2.
*N	4563307	HLR	Sunset Due – No Change
*O	5007155	HLR DCON	Changed the substances with " and Proprietary "to "Trade Secret". Removed distribution and posting from the document history page.

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